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I, JANENE PEISKER, TEAM LEADER EXAMINATION SUPPORT AND SALES hereby certify that annexed is a true copy of the Provisional specification in connection with Application No. PS 3226 for a patent by COCHLEAR LIMITED as filed on 28 June 2002.

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JANENE PEISKER  
TEAM LEADER EXAMINATION  
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**AUSTRALIA**

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**Cochlear Limited**

**PROVISIONAL SPECIFICATION**

*Invention Title:*

*Coil and cable tester*

The invention is described in the following statement:

### Field of the Invention

The present invention is a device to assist in testing the functionality of external equipment associated with an implantable device. More preferably, the present invention is a tool to assist in the diagnosis, analysis and servicing of a cochlear implant system.

### Description of the Prior Art

10

Over recent times, the use of implantable devices to assist in restoring functionality to individuals who have lost the capability for that function to be performed naturally by the body has become increasingly common. Examples of such devices include pacemakers, defibrillators, cochlear implants, hearing aids and functional electrical stimulation (FES) devices.

15

Fundamental to all currently available implantable devices has been the presence of an external controller unit to control the implantable portion of the device. This external controller unit can communicate with the implantable device through a variety of means to deliver various forms of control signals to allow the implantable device to perform its desired function.

20

With regard to cochlear implants, such devices have proven successful in restoring the sensation of hearing to individuals who have previously been considered as being severely or profoundly deaf, and unable to obtain benefit from conventional hearing aid devices. In such individuals, the hair cells of the cochlea have been damaged and are no longer able to transfer the mechanical vibration of the fluid inside the cochlea into electrical signals to be perceived by the brain as sound. One such cochlear implant device that has proven successful in such cases is described in US Patent No. 4,532,930, the contents of which are incorporated herein by reference. In such a device the cochlear implant bypasses the role of the hair cells and directly delivers electrical stimulation to the nerves in the cochlea, representative of speech and environmental sounds. The neural impulses generated by the electrical signals are then sent to the brain and interpreted as sound. The electrical stimulation

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35

is usually delivered to selected nerve sites within the cochlea by an array of electrodes, electrically connected to an implanted stimulator device.

Traditionally, the implanted stimulator device receives a coded sound  
5 signal from an external sound processor device, and this coded signal directs  
the implanted stimulator device to deliver the appropriate electrical stimulation  
to the appropriate stimulation site to reproduce the corresponding sound. The  
implanted stimulator is equipped with electronic circuitry and switches to allow  
stimulation to be delivered to a number of electrodes simultaneously or in very  
10 quick succession to provide detailed sound perception.

The external unit provides coded signal to the implanted stimulator via a  
transcutaneous link, such as a radio frequency (RF) link, and the coded signal  
is directly representative of the surrounding sound as detected by an external  
15 microphone. The external microphone may be mounted on the external sound  
processor or may be remote from the external sound processor but connected  
via a suitable link.

In general, the basic function of the external processor is to take the  
20 audio signal from the microphone and to process it according to a particular  
speech coding strategy, to produce a signal that contains stimulation  
information for the implant. In that regard speech processors are quite patient-  
specific and whilst the system hardware is relatively common for all users, the  
software used as well as the benefits gained from different software packages  
25 varies considerably from patient to patient.

It can therefore be appreciated that for devices such as cochlear  
implants, successful operation of the device relies upon the external and  
implanted portions of the device working together to produce the desired  
30 functionality. Should any one part of the external or implanted hardware  
malfunction, the capacity of the device to perform its function is severely  
affected. In the case of cochlear implants, this could result in uncomfortable or  
unsafe stimulation, or more commonly, in the recipient losing the capacity to  
detect sound.

For this reason it is important that should a recipient experience problems with their device, they must feel confident that the problem can be quickly detected and where possible, resolved so that the device can be returned to normal operation with minimal inconvenience to the recipient.

5

At present, in the unfortunate event of a cochlear implant recipient experiencing a difficulty or malfunction causing them to lose system functionality, the recipient must contact a local clinic or agent that has been assigned to deal with such issues. The clinic or agent is in most cases familiar with the recipient's needs and requirements and has full records of the recipient's history and any past problems they may have experienced.

In most cases it has been found that the major source of system problems and faults is related to the external system components, namely the external cables connecting the various external components, as well as the external transmitter coil. This is primarily due to the fact that these components are exposed to everyday handling and exposure to the elements, and as such are more likely to suffer damage.

Currently, if a recipient reports a device as being faulty, the clinic or agent firstly checks the recipient's external equipment for malfunction. This is done by swapping the suspected faulty device with a known non-faulty device and assessing whether the problem has been resolved. This process is repeated for all cables and coils and as such the clinic must carry a stock of spare parts for every piece of external equipment, which is often not economically feasible for smaller clinics. Such a process is understandably time consuming and reduces the efficiency of the clinic to deal with important and more time intensive tasks, such as implant programming sessions.

The present invention aims to solve the abovementioned problems by providing a device that can simply test the external components of an implantable system and give a direct indication as to whether the component is functional or not. Such a device will be able to be used by the individual or the clinic to diagnose problems immediately and avoids the need for the clinic to spend unnecessary time diagnosing and correcting such simple problems and

reduce the need for them to carry a stock of spare external components for trouble shooting purposes.

Any discussion of documents, acts, materials, devices, articles or the like which has been included in the present specification is solely for the purpose of providing a context for the present invention. It is not to be taken as an admission that any or all of these matters form part of the prior art base or were common general knowledge in the field relevant to the present invention as it existed before the priority date of each claim of this application.

10

#### Summary of the Invention

Throughout this specification the word "comprise", or variations such as "comprises" or "comprising", will be understood to imply the inclusion of a stated element, integer or step, or group of elements, integers or steps, but not the exclusion of any other element, integer or step, or group of elements, integers or steps.

According to one aspect, the present invention is a testing apparatus for testing at least one component of an implantable tissue-stimulating device and diagnosing problems associated therewith, the testing device comprising:

at least one testing station for receiving said at least one tested component and making an electrical and/or inductive connection thereto;

at least one testing circuit adapted to apply at least one test to said tested component and measure the response of the tested component to said test;

a memory means for storing data indicative of the response to said test of at least one equivalent component that is known to be operational;

a comparator means for comparing the response of said tested component to said test to said data and determining whether said response is at least substantially similar to said data; and

an output means for outputting a result of said comparison.

In one embodiment, the tissue-stimulating device is a hearing prosthesis such as a cochlear implant system. In this embodiment, said at least one tested component preferably comprises a cable and/or a transmitter coil

adapted to be connected to an external speech processor component of a cochlear implant system.

The testing apparatus preferably comprises a case having a first surface  
5 having the testing stations as defined herein.

In one embodiment, the testing apparatus is preferably adapted to test more than type of component. For example, different speech processors can be adapted to operate with different cable and/or coil combinations. In different  
10 embodiments, the testing apparatus can be adapted to test two, three, four, or more types of cables and/or two, three, four, or more types of cable and coil combinations. Where the testing apparatus is capable of testing two different types of cable, the apparatus preferably has at least two testing stations for providing an electrical connection to said cables. Where the testing apparatus  
15 is capable of testing three or more cables, the testing apparatus preferably has at least three or more testing stations, and so on.

Each cable testing station, where there is more than one, is preferably adapted to test only one type of cable. Where there are two or cable testing  
20 stations, each station is adapted to test a different type of cable from that of the other cable test stations. Each cable testing station can be a socket provided in the first surface of the case and having a shape that is adapted to receive a particular cable design and no other. Each socket design preferably allows electrical connection to the cable under test.

25

Each testing apparatus can have a single coil testing station. In another embodiment, the testing apparatus can have two or more coil testing stations. The coil testing apparatus preferably comprises a planar area in the first surface of the case on which the tested coil can be placed. The planar area  
30 can have an indicia means provided thereon that provides an indication of where the tested coil should be placed to ensure an appropriate test of the tested coil is undertaken. In one embodiment, the indicia means can comprise a pictorial representation of a transmitter coil. Where the testing apparatus is able to test more than one coil design, the planar area can have more than one  
35 unique indicia means provided thereon. For example, the planar area can have

different pictorial representations of the different coil types that can be tested using the apparatus.

5 The tested coil preferably has a magnet that aligns itself correctly on the coil test station via another attracting magnet positioned below the planar surface of the case. The attractive force between the magnets is preferably used to maintain the tested coil in the correct place for testing.

10 Each tested coil preferably has a cable extending therefrom that is also testable by the testing apparatus. In a preferred embodiment, a tested coil with a cable extending therefrom is tested by positioning the coil in the appropriate location on the planar surface and then inserting the other end of the cable into the appropriate cable test socket of the apparatus.

15 The testing apparatus is preferably capable of sensing the type of coil, cable, or coil and cable combination that is under test and then access from the memory means the appropriate stored data for use by the comparator means of the apparatus.

20 In a preferred embodiment, the testing apparatus includes a control means that controls the overall function of the apparatus. The control means can comprise a microcontroller. The microcontroller can further preferably act as the memory means for the testing apparatus. The microcontroller further preferably comprises a microprocessor having an analogue to digital converter  
25 (ADC) to digitise the measurements representative of the tested component. The microprocessor is further preferably adapted to run software that controls the operation of the testing apparatus.

30 In a preferred embodiment, the measurements from said one or more testing circuits are in the form of current and voltage levels.

It is envisaged that said data indicative of the response of said equivalent operational component is preferably in the form of voltage and current ranges associated with non-faulty cables and transmitter coils used in cochlear implant  
35 systems.

In a further embodiment, the memory means is programmable to enable the stored data to be upgraded and altered according to the design requirements of the components to be tested.

5 In a further embodiment, the output means comprises one or more lights that can be illuminated or turned off in response to the outcome of the test. In a preferred embodiment, a light illuminates if the tested component passes the test and fails to illuminate if the tested component is inoperative or faulty. In one embodiment, the light can be a light emitting diode (LED), such as red  
10 LED.

In one embodiment, the LED can be adapted to only illuminate only when the response of said tested component is determined by the comparator means to be identical to the response of said equivalent operational  
15 component. It is, however, more likely that the LED can be adapted to illuminate when the voltage and/or current response of said tested component is within a predetermined range of what are considered acceptable values for that component.

20 In operation, the microcontroller of the apparatus can send a signal to the coil testing circuit comprising a socket voltage driver that drives the coil preferably with an AC square wave voltage source at or near the resonant frequency of the coil. This resonant frequency is dependent on the type of coil being tested. For example, in some instances it may be near 2.5 or 5.0 MHz.  
25 A simple push-pull square wave voltage driver circuit, similar to those used in external speech processors can be used for this purpose.

If the coil and cable combination plugged into the device is correctly functioning, a coil in the testing circuit will preferably resonate through an  
30 inductive coupling between the tested coil and the coil testing circuit and the coil current will have a value determined by the coil impedance at its resonant frequency, which is typically a few tens of Ohms, or less. In testing the coil and cable combination in accordance with the present invention, the apparatus preferably monitors the coil current and if the current is found to be above an  
35 acceptable value, the coil and cable combination pass the test and the device indicates a PASS to the tester via illuminating the LED 35. If the coil and cable

combination is found to be faulty (eg. coil cable is broken, connector faulty etc) the device indicates a fail by not illuminating the LED, or alternatively, by emitting a FAIL signal via another indicator means. In the event of a failure, most coil and cable combinations either involve a complete failure of the circuit  
5 or a detuning of the circuit in some way. Therefore in these fault conditions, the amplitude of the coil current will be reduced below a predetermined threshold and the coil will be detected as having failed.

In a preferred embodiment, the testing circuit for the coil and cable in  
10 combination preferably comprises a voltage rectification and current sensing circuit that measures the compliance of the coil and cable combination and outputs the result to the microcontroller.

Where the compliance of a cable is to be tested, a DC potential can be  
15 placed on one cable lead and the potential of another lead of the cable can be measured. The other end of the cable is preferably plugged into a resistor load network connecting all the cable leads together. When all the cable's leads are functioning normally a specific voltage, determined by the resistor load network, is expected on the sensed lead. If a fault occurs (one line open circuit or  
20 shorted to another) this will change the current flow in the cable and cause the voltage in the sensed lead to change. The voltage is preferably sensed by digitising it using the microprocessor ADC with software used to determine whether the sensed value corresponds to a normal or a faulty cable. When a voltage is sensed which corresponds to a normal cable, the microprocessor  
25 can illuminate the LED in the manner as discussed above.

The present invention provides an apparatus that can test external components of a cochlear implant system in a manner that does not require the person conducting the test to have advanced knowledge of the operation of the  
30 tested component. It provides a relatively quick and straightforward answer to the question of whether the component is operative or not.

#### Brief Description of the Drawings

35 Examples of the invention will now be described with reference to the accompanying drawings in which:

Figure 1 is a pictorial representation of a conventional cochlear implant system;

5        Figure 2 is a pictorial representation of a tester unit in accordance with one embodiment of the present invention;

Figure 3 is a block functional diagram of the tester unit of the present invention;

10

Figure 4 is a circuit diagram showing a circuit capable of testing a coil/cable combination according to one embodiment of the present invention; and

15        Figure 5 is a circuit diagram showing a circuit capable of testing a cable according to one embodiment of the present invention.

#### Preferred Mode of Carrying out the Invention

20        Before describing the features of the present invention, it is appropriate to briefly describe the construction of a cochlear implant system with reference to Fig. 1.

Cochlear implants typically consist of two main components, an external  
25        component including a speech processor 29, and an internal component including an implanted receiver and stimulator unit 22. The external component includes an on-board microphone 27. The speech processor 29 is, in this illustration, constructed and arranged so that it can fit behind the outer ear 11. Alternative versions may be worn on the body. Attached to the speech  
30        processor 29 is a transmitter coil 24 which receives electrical signals through a cable 10 and transmits signals to the implanted unit 22 via a radio frequency (RF) link.

The implanted component includes a receiver coil 23 for receiving power  
35        and data from the transmitter coil 24. A cable 21 extends from the implanted receiver and stimulator unit 22 to the cochlea 12 and terminates in an electrode

array 20. The signals thus received are applied by the array 20 to the basilar membrane 8 thereby stimulating the auditory nerve 9. The operation of such a device is described, for example, in US Patent No. 4,532,930.

5       The sound processor 29 of the cochlear implant can perform an audio spectral analysis of the acoustic signals and outputs channel amplitude levels. The sound processor 29 can also sort the outputs in order of magnitude, or flag the spectral maxima as used in the SPEAK strategy developed by Cochlear Ltd.

10

As previously mentioned, when a problem is reported by a cochlear implant recipient, the clinic responsible for identifying and resolving the problem, often follow a systematic approach. It is established that there may be a number of possible causes for the problem, such as a loss of implant  
15       function, and these causes may be related to: the external hardware; physiological or psychological changes; or the implanted hardware. As the external hardware is often the simplest and most obvious source of problems, the clinician often starts with assessing the external hardware for faults before consideration is given to the other two relatively more complicated problems.

20

In the case of the cochlear implant as described in Figure 1, the main external components are the external sound processor 29, the transmitter coil 24, and the connector cable(s) 10. The present invention addresses a method and device to simply and quickly test the transmitter coil and connector cables  
25       for proper electrical function, such that the clinician or recipient can quickly solve such problems or eliminate the possibility of such problems being a contributing factor to the reported problem.

In terms of the transmitter coil and cables used in cochlear implants, their  
30       function is to transmit encoded radio frequency signals from the external speech processor to the internal component of the implant that is positioned beneath the recipient's skin. Therefore it is both the coil and cable that form part of the resonant RF circuit which is loosely coupled to the receiver coil in the implant. The RF is generated at either 2.5 MHz or 5.0 MHz depending  
35       upon the design of the speech processor and implant. In operation, the

transmitter coil and the receiver coil are tuned to frequencies, for example, close to but not exactly at, either 2.5 or 5.0 MHz.

In construction the coils usually consist of a number of turns of wire, typically around 30mm in diameter, with an injection moulded plastic covering all components. In the centre of the coil there may be positioned a magnet used to locate and hold the transmitter coil in an appropriate external position relative to the implant or receiver coil, which also has a magnet positioned therewith.

10

In cochlear implants produced by the present applicant, depending upon the type of speech processor used, there may be a number of different transmitter coils designed to operate with each of the different speech processors. These coils are often not compatible with processors other than that which they have been designed for, and hence interchanging of coils may result in the implant receiving no signal, a non-meaningful signal, or an incomplete or garbled signal. One way of overcoming the problem of using the wrong transmitter coil with the wrong processor has been to use different electrical connecting sockets for each coil, matching with the socket for the speech processor. This has also resulted in the need for a wider variety of cables connecting the speech processor to the transmitter coil, with corresponding sockets to match the particular device.

Figure 2 is a top view of one embodiment of the present invention. The tester unit is represented as numeral 30 and includes a plurality of test stations designated by reference numerals 32, 33 and 34 arranged on the top surface of the unit 30 for testing the external coil and cables of an implantable unit. In test stations 32 and 33, a plurality of connector sockets 31 are arranged as shown with each socket in test station 32 having a corresponding socket arranged in test station 33. The connector sockets 31 are designed to receive the various types of cables provided with the implantable system, with each free end of a cable being connected to the appropriate socket in test station 32 and 33, for testing. Each of the connector sockets 31 are designed to receive only one type of cable, to ensure that the correct integrity test is carried out on that cable in accordance with the operating requirements. Arranged on the top surface of the unit 30 is an indicator means 35, for example an LED, which provides an

indication to the tester as to whether the cables pass the test or not. In a preferred embodiment the indicator means 32 may emit a green light if the cable is OK and emit no light if the cable is faulty. Alternatively, a red light may be emitted if the cable is found to be faulty. Other variations may also be implemented to convey this information to the tester, which fall within the scope of the present invention.

The unit 30 also includes a transmitter coil test station 34 to enable the transmitter coils to be integrity tested. In the embodiment as shown in Figure 2, the transmitter coil test station 34 is positioned on the upper surface of the unit 30 to allow a transmitter coil (not shown) to be placed thereon. The magnet of the transmitter coil to be tested aligns itself correctly on the transmitter coil test station 34 via another attracting magnet arranged within the unit 30, just below the surface of the unit, so that the attracting force of the magnets maintains the transmitter correctly in place for testing. As is shown in Figure 2, the transmitter coil test station 34 may include indicia means 36, such as a pictorial representation of a transmitter coil placed correctly upon the test station 34. By placing the transmitter coil to be tested over this indicia means 36, the transmitter coil is automatically placed in the appropriate area on the test station 34 for testing.

Once the coil has been placed upon the test station 34 it is connected via a cable to a connecting socket 31 of test station 32. As the coil to be tested is designed to receive only one type of cable and the cable will only fit one of the connecting sockets 34 on test station 32, the unit 30 can then determine the type of coil being tested and can access the appropriate test parameters from the stored memory (discussed in more detail below).

The testing unit 30 also includes an on/off switch 37 and may also include various indicia means which may aid the tester in using the unit. Such indicia means may include graphics grouping the sockets together and marking them with descriptive text indicating which cables they relate to, as well as similar labelling for the transmitter coil test station indicating the type of coil to be tested.

Figure 3 is a functional block diagram of the tester unit 30 showing how the system operates in a functional mode. The tester unit 30 can be considered to consist of a microcontroller 41, a receiver coil voltage rectification and current sensing circuit 42, a receiver coil 44, a socket voltage driver 43, a cable test circuit 45, a series of sockets 46, a series of LEDs 35 and an on/off switch 48.

The microcontroller 41 is in the depicted embodiment a programmable microcontroller that essentially controls the application of test signals to the appropriate sockets at the appropriate times and also digitises and measures the appropriate measurement signals at the appropriate times. An analogue to Digital Converter (ADC) is built into the microprocessor 41 to digitise the measurements, and the microprocessor 41 contains software to compare the measured values to the known limits which have previously been established for the coil and/or cable being tested and which are stored within a memory of the microprocessor 41.

The receiver coil voltage rectification and current sensing circuit 42 essentially consists of a circuit that measures a parameter related to the receiver coil current and a rectified voltage inductively induced in the receiver coil 44 which is in close proximity to and aligned with the transmitter coil being tested.

The socket voltage driver 43 activates the sockets and allows the testing of both the coils and cables to be undertaken by providing each socket with the required voltage as dictated by the microcontroller 41.

The cable test circuit 45 monitors the functionality of the cables being tested by sensing the current being passed therethrough.

The series of sockets 46 allow the coils and/or cables to be connected to the test unit such that their operation can be tested. Under direction from the circuit 43, the sockets can be activated and the coil and/or cable tested.

The series of LEDs 35 provide indicators visible to the tester regarding whether the cables and/or coils being tested meet the requirements. This could

include one LED representing a PASS, or a series of LEDs representing a PASS and/or FAILURE.

The on/off switch 48 toggles the power to the system on or off.

5

The system will now be described in use, with reference to Figures 2, 3 and 4. In order to test the operation of a particular transmitter coil, the coil is placed on the transmitter coil test station 34 where it is held in place by an alignment magnet that cooperates with the magnet of the transmitter coil. The alignment magnet is preferably arranged on the inside of the unit housing below the area marked for placement of the transmitter coil under test, this area being shown in Figure 2 by reference numeral 36. The purpose of the alignment magnet is to ensure that the transmitter coil under test is located within a 1mm radius of its designed position. A cable is then connected from the transmitter coil to a provided socket, shown in Figure 2 by reference numeral 31, the socket 31 corresponding to receive the correct cable connector.

Once the coil and cable are in place, the microcontroller 41 can send a signal to the socket voltage driver 43 to drive the coil with an AC square wave voltage source at or near the resonant frequency of the coil. This resonant frequency is dependent on the type of coil being tested, for example in some instances it may be near 2.5 or 5.0 MHz. A simple push-pull square wave voltage driver circuit, similar to those used in external speech processors is adequate for this purpose and is shown in Figure 4 by reference numeral 43.

If the coil/cable combination plugged into the device is correctly functioning, the circuit will resonate and the coil current will have a value determined by the coil impedance at its resonant frequency, which is typically a few tens of Ohms, or less. In testing the coil/cable combination in accordance with the present invention, the method involves monitoring the coil current and if the current is found to be above an acceptable value, the coil/cable combination passes the test and the device indicates a PASS to the tester via illuminating the LED 35. If the coil/cable combination is found to be faulty (eg. coil cable is broken, connector faulty etc) the device indicates a fail by not illuminating the LED, or alternatively, by emitting a FAIL signal via another

indicator means (not shown). In the event of a failure, most coil/cable combinations either involve a complete failure of the circuit or a detuning of the circuit in some way. Therefore in these fault conditions, the amplitude of the coil current will be reduced below a predetermined threshold and the coil will be  
5 detected as having failed.

The Receiver Coil Voltage Rectification and Current Sensing Circuit 42 measures the compliance of the coil/cable combination and outputs the result to the microcontroller 41. As mentioned above, the simplest way to test the coil  
10 involves monitoring the current, and this can be done in a number of different ways.

Figure 4 depicts a circuit suitable for this purpose in accordance with a preferred embodiment. In Figure 4, the socket voltage driver is shown as 43,  
15 the Receiver Coil Voltage Rectification and Current Sensing Circuit is shown as 42, the coil being tested is shown as 53, and the receiver coil is shown as 44.

The microprocessor (not shown in Figure 4) produces a crystal controlled AC drive signal at or near the resonant frequency of coil 53 (as described  
20 above). This signal controls the socket voltage driver circuit 43, which consists of a simple push-pull driver as shown. AC current flowing in the coil 53 induces a mean voltage across the 10 Ohm resistor of the Current Sensing Circuit 42, and this voltage is smoothed by the 10uF capacitor. This smoothed voltage is then sent to the microprocessor 41, being representative of the coil current  
25 sense signal.

The field sense circuit of the Receiver Coil Voltage Rectification and Current Sensing Circuit 42 includes a multi-turn coil 44 which is in close proximity to the coil 53. The AC current flowing in the coil 53 induces an AC  
30 voltage in the adjacent receiver coil 44, and this voltage is also rectified and smoothed by the remainder of this circuit and is sent to the microcontroller 41, being representative of the field sense signal.

Once the Receiver Coil Voltage Rectification and Current Sensing Circuit  
35 42 has taken the measurements representative of the coil current sense signal and the field sense signal, the microprocessor utilises stored software to

determine whether or not the values measured for the coil, correspond to the desired range of values within the design specification of that particular coil. If these values do fall within the design specification range for that coil, a signal is sent to the LED 35 to illuminate and so convey to the user that the device has passed the test. Otherwise, either a FAIL signal will be conveyed to the user or the LED 35 will not be illuminated, which is indicative of a FAIL.

Figure 5 shows a circuit for testing the compliance of a cable only, according to an embodiment of the present invention. In this embodiment, measurements are made by placing a DC potential on one cable lead and measuring the potential on another. The other end of the cable is plugged into a resistor load network connecting all the cable leads together. When all the cable's leads are functioning normally a specific voltage, determined by the resistor load network, is expected on the sensed lead 60. If a fault occurs (one line open circuit or shorted to another) this will change the current flow in the cable and cause the voltage in the sensed lead 60 to change. The voltage is sensed by digitising it using the microprocessor 41 ADC and software is used to determine whether the sensed value corresponds to a normal or a faulty cable. When a voltage is sensed which corresponds to a normal cable the microprocessor 41 illuminates the "Pass" LED 35 in the manner as discussed above.

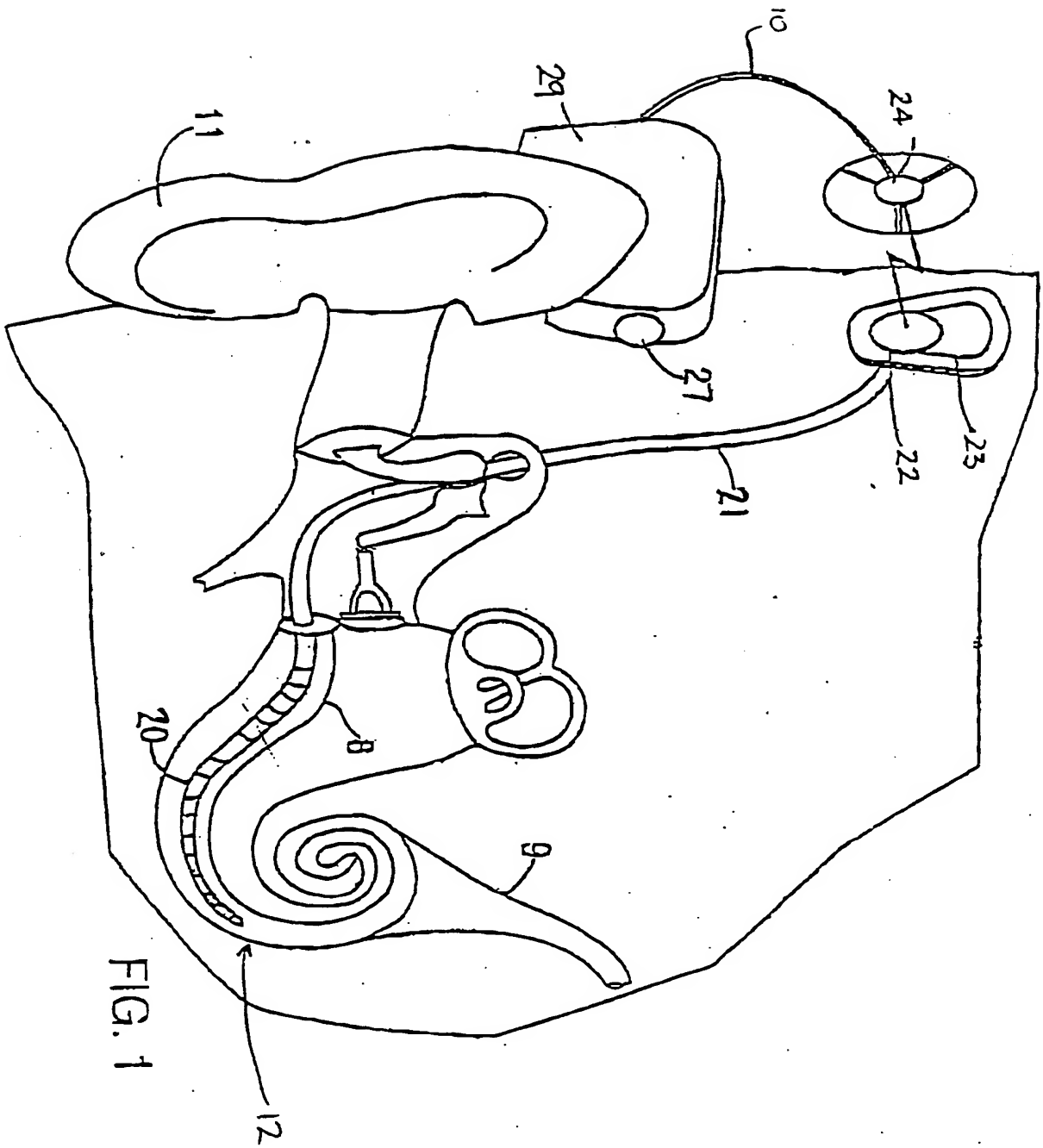
Figure 5 depicts a test undertaken on a typical two lead cable. In this example, if the cable is normal (i.e. both leads connected and not shorted), the two resistors create a potential divider and the sensed voltage is equal to 50% of the supply voltage. If either lead is open circuit the sensed voltage becomes equal to ground. If the leads are shorted the sensed voltage is equal to the supply rail voltage. A similar arrangement can be used for cables with 3 or more leads.

It will be appreciated by persons skilled in the art that numerous variations and/or modifications may be made to the invention as shown in the specific embodiments without departing from the spirit or scope of the invention  
5 as broadly described. The present embodiments are, therefore, to be considered in all respects as illustrative and not restrictive.

Dated this twenty eighth day of June 2002

Cochlear Limited  
Patent Attorneys for the Applicant:

F B RICE & CO



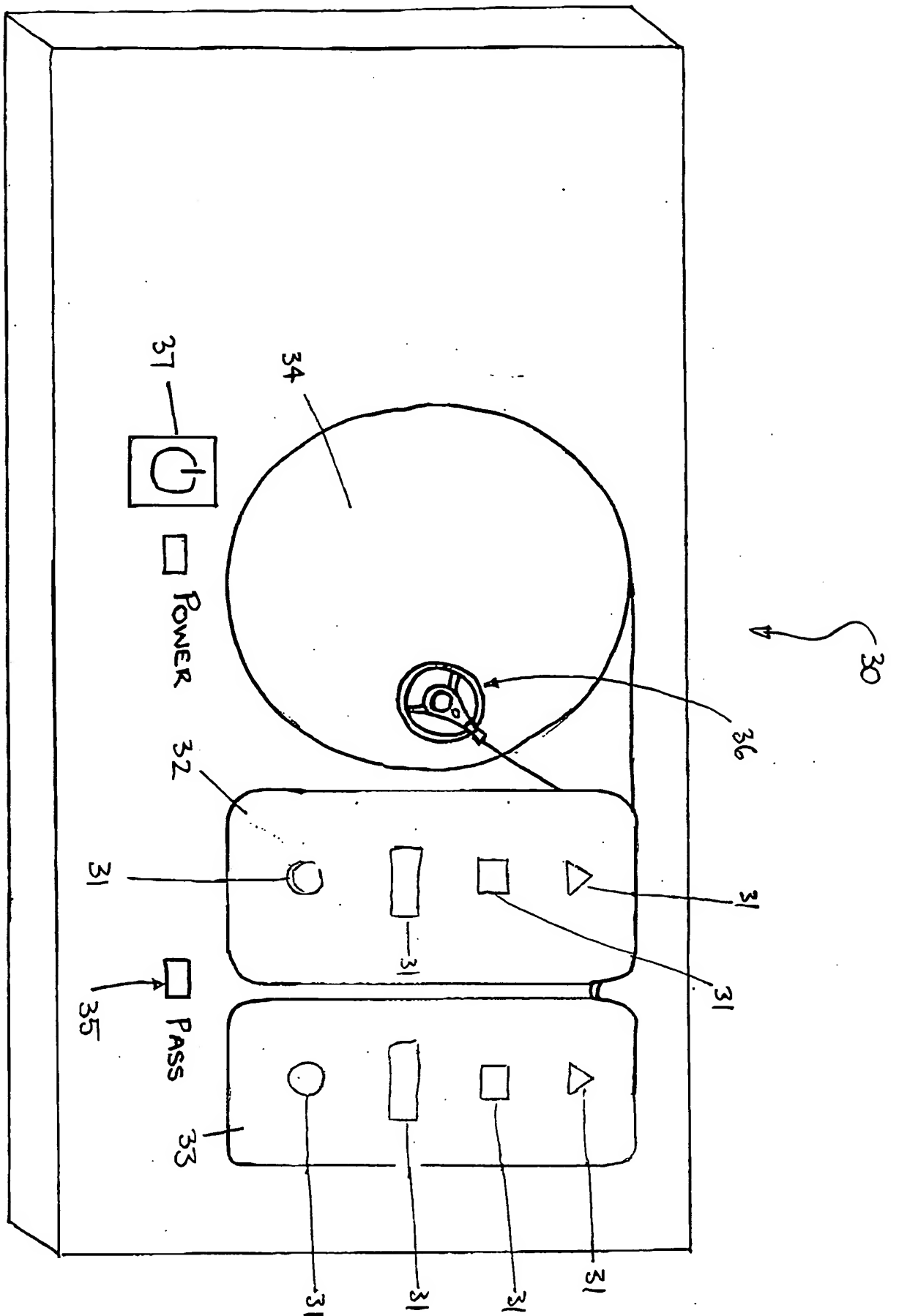


Figure 2

3/5

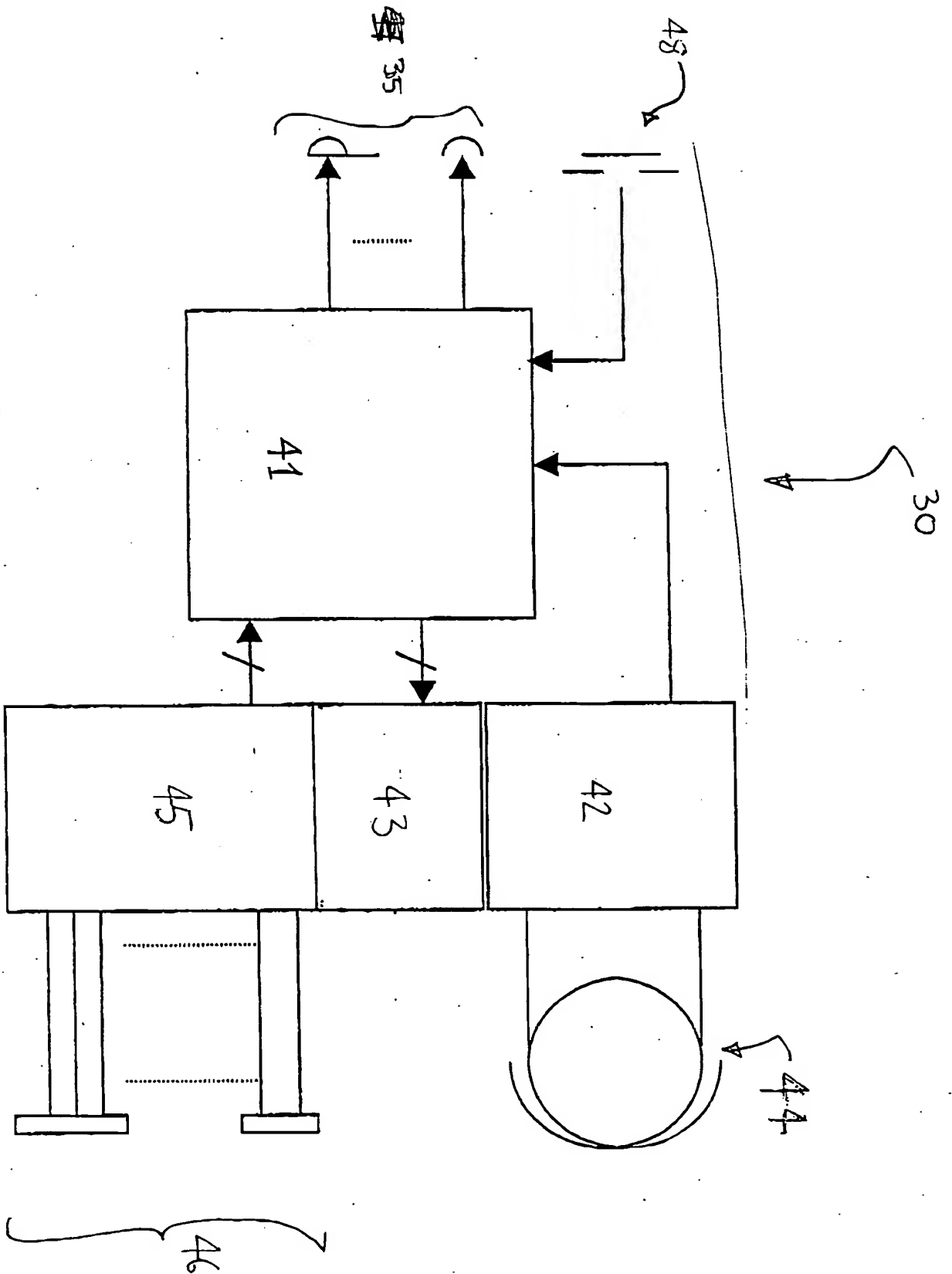


Figure 3.

4/5

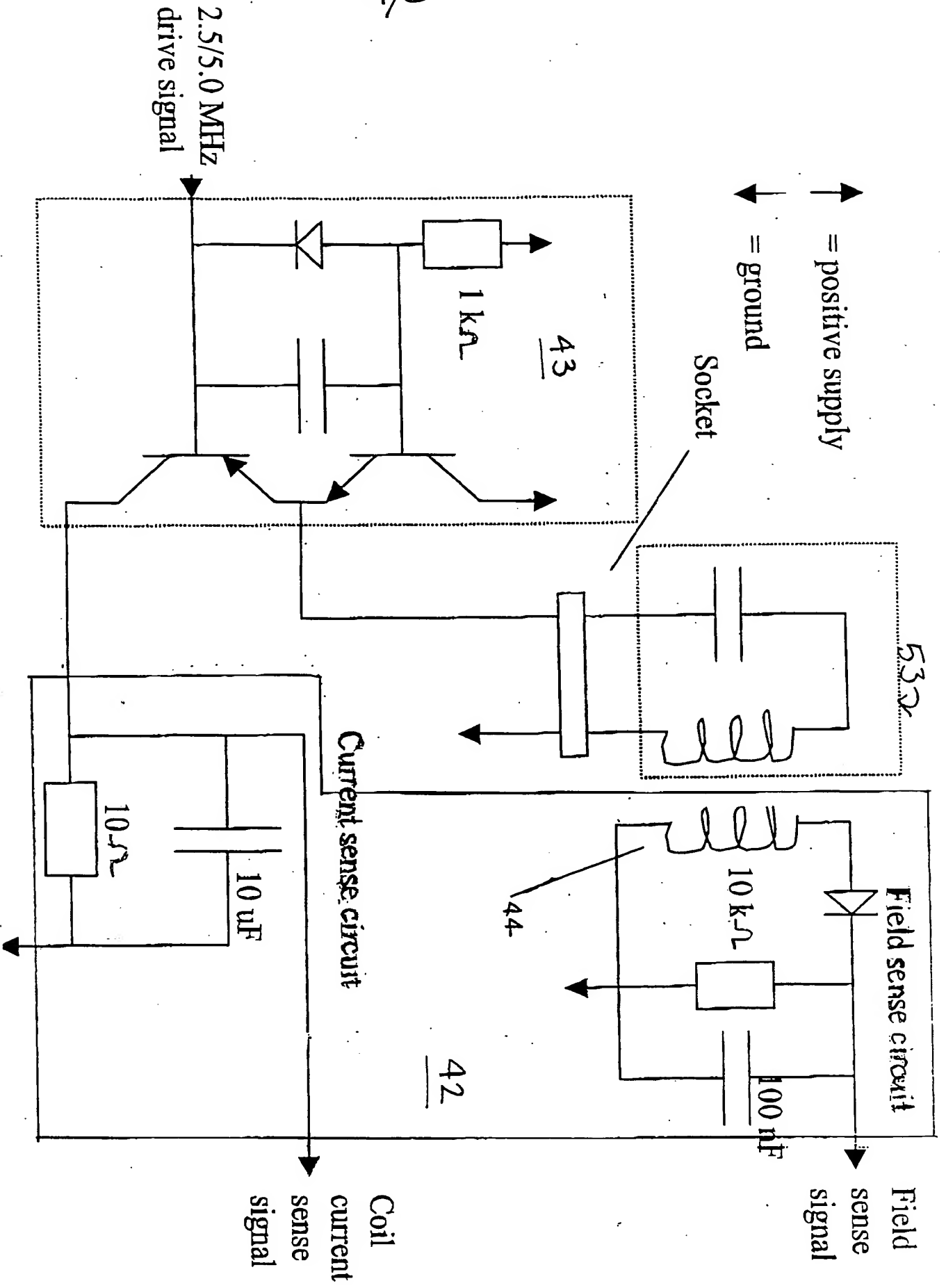


Figure 4

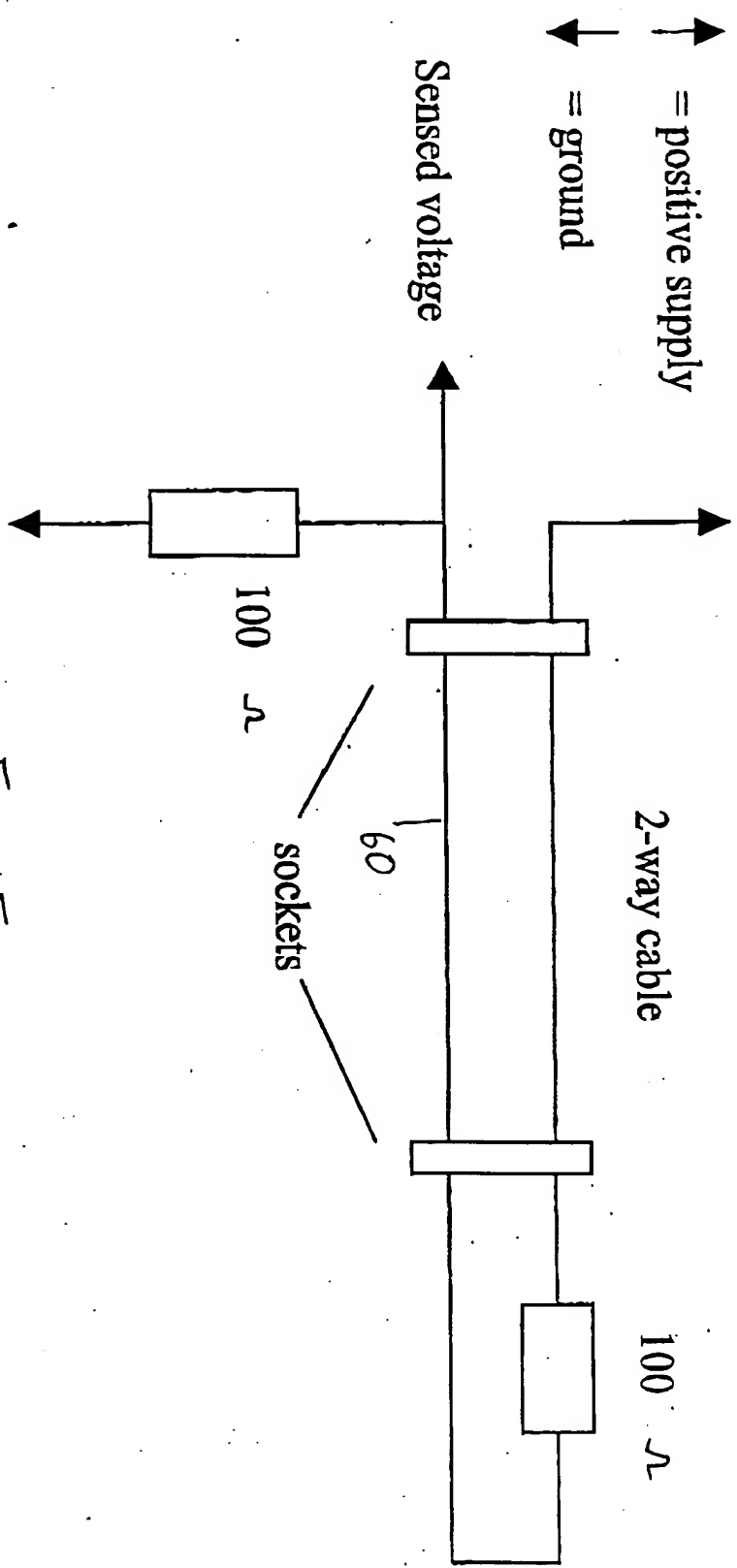


Figure 5

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